

Notice of References Cited

Application/Control No.

10/533,341

Applicant(s)/Patent Under
Reexamination
BARTON ET AL.

Examiner

Rei-tsang Shiao, Ph.D.

Art Unit

1626

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	V	Coppola et al., 1980, CAS: 92:146570. /			
	W	Hendrickson et al., 1976, CAS: 84:16883. /			
	X	Albrecht's, 1978, CAS: 89: 109326. /			

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